Applicant(s)/Patent Under Reexamination Application/Control No. 09/457,952 SEBIRE ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 David Q. Nguyen 2681 **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,658,045 B1	12-2003	Jin, Xin	375/147
	В	US-			
	С	US-			
	D	US-			
	Е	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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